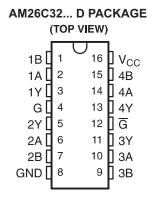
AM26C32-EP QUADRUPLE DIFFERENTIAL LINE RECEIVER

SLLS870-NOVEMBER 2007

FEATURES

- Controlled Baseline
 - One Assembly
 - One Test Site
 - One Fabrication Site
- Extended Temperature Performance of -55°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree (1)
- Meets or Exceeds the Requirements of ANSI TIA/EIA-422-B, TIA/EIA-423-B, and ITU Recommendation V.10 and V.11
- (1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Low Power, I_{CC} = 10 mA Typ
- ±7 V Common-Mode Range With ±200 mV Sensitivity
- Input Hysteresis . . . 60 mV Typ
- t_{pd} = 17 ns Typ
- Operates From a Single 5 V Supply
- 3-State Outputs
- Input Fail-Safe Circuitry
- Improved Replacements for AM26LS32



DESCRIPTION/ORDERING INFORMATION

The AM26C32 is a quadruple differential line receiver for balanced or unbalanced digital data transmission. The enable function is common to all four receivers and offers a choice of active-high or active-low input. The 3-state outputs permit connection directly to a bus-organized system. Fail-safe design specifies that if the inputs are open, the outputs always are high.

The AM26C32 devices are manufactured using a BiCMOS process, which is a combination of bipolar and CMOS transistors. This process provides the high voltage and current of bipolar with the low power of CMOS to reduce the power consumption to about one-fifth that of the standard AM26LS32, while maintaining ac and dc performance.

The AM26C32 is characterized for operation over the extended temperature range of -55°C to 125°C.

ORDERING INFORMATION(1)

T _A	PACK	AGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
–55°C to 125°C	SOIC - D	Reel of 2500	AM26C32MDREP	26C32EP	

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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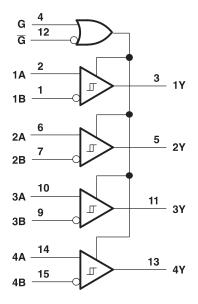


FUNCTION TABLE (each receiver)

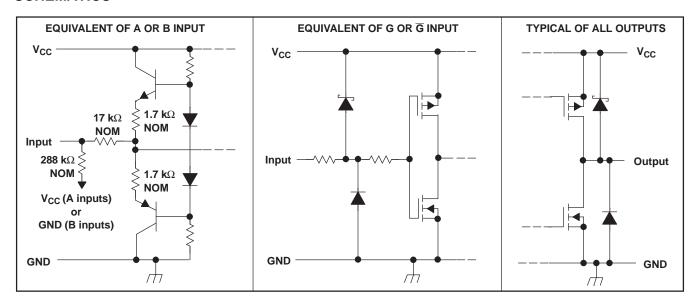
DIFFERENTIAL	ENA	BLES	OUTPUT
INPUT	G	G	Υ
V >V	Н	Х	Н
$V_{ID} \ge V_{IT+}$	Х	L	Н
\/ .\/ .\/	Н	Х	?
$V_{IT-} < V_{ID} < V_{IT+}$	Х	L	?
\\	Н	Х	L
V _{ID} ≤ V _{IT}	Х	L	L
X	L	Н	Z



LOGIC DIAGRAM (POSITIVE LOGIC)



SCHEMATICS



AM26C32-EP QUADRUPLE DIFFERENTIAL LINE RECEIVER

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ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

				MIN	MAX	UNIT
V_{CC}	Supply voltage ⁽²⁾				7	V
	lanut valta aa ranga	A or B inputs		-11	14	V
VI	Input voltage range	G or G inputs		-0.5	V _{CC} + 0.5	V
V_{ID}	Differential input voltage range		-14	14	V	
Vo	Output voltage range				V _{CC} + 0.5	V
Io	Output current				±25	mA
0	Deckage thermal impedance (3)(4)	D package			73	°C ///
θ_{JA}	Package thermal impedance (3)(4)	PW package			108	°C/W
TJ	Operating virtual junction temperature			150	°C	
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds					°C
T _{stg}	Storage temperature range		-65	150	°C	

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
V_{IC}	Common-mode input voltage			±7	V
I _{OH}	High-level output current			-6	mA
I _{OL}	Low-level output current			6	mA
T _A	Operating free-air temperature	-55		125	°C

⁽²⁾ All voltage values, except differential output voltage, V_{OD}, are with respect to network GND. Currents into the device are positive and currents out of the device are negative.

⁽³⁾ Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) - T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can affect reliability.

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ELECTRICAL CHARACTERISTICS

over recommended ranges of V_{CC} , V_{IC} , and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST C	MIN	TYP ⁽¹⁾	MAX	UNIT		
V	Differential input high threshold voltege	$V_O = V_{OH}$ (min),	$V_O = V_{OH}$ (min), $V_{IC} = -7 \text{ V to } 7 \text{ V}$			0.2	V	
V _{IT+}	Differential input high-threshold voltage	$I_{OH} = -440 \mu A$	$V_{IC} = 0 \text{ to } 5.5 \text{ V}$			0.1	V	
V	Differential input low threehold voltage	$V_{O} = 0.45 \text{ V},$	$V_{IC} = -7 \text{ V to } 7 \text{ V}$	-0.2 ⁽²⁾			V	
V _{IT}	Differential input low-threshold voltage	I _{OL} = 8 mA	V _{IC} = 0 to 5.5 V	-0.1 ⁽²⁾			V	
V _{hys}	Hysteresis voltage (V _{IT+} – V _{IT-})		·		60		mV	
V_{IK}	Enable input clamp voltage	V _{CC} = 4.5 V,	I _I = -18 mA			-1.5	V	
V_{OH}	High-level output voltage	V _{ID} = 200 mV,	$I_{OH} = -6 \text{ mA}$	3.8			V	
V _{OL}	Low-level output voltage	$V_{ID} = -200 \text{ mV},$	I _{OL} = 6 mA		0.2	0.3	V	
I _{OZ}	Off-state (high-impedance state) output current	V _O = V _{CC} or GND			±0.5	±5	μΑ	
	Line input current	V _I = 10 V,	Other input at 0 V			1.5	A	
I _I	Line input current	$V_{I} = -10 \text{ V},$	Other input at 0 V			-2.5	mA 5	
I _{IH}	High-level enable current	V _I = 2.7 V			20	μΑ		
I _{IL}	Low-level enable current	V _I = 0.4 V			-100	μΑ		
rı	Input resistance	One input to groun	12	17		kΩ		
I _{CC}	Supply current	V _{CC} = 5.5 V			10	15	mA	

SWITCHING CHARACTERISTICS

over recommended ranges of operation conditions, $C_L = 50 \text{ pF}$ (unless otherwise noted)

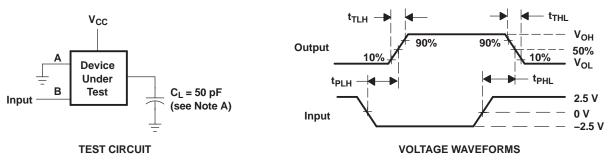
	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{PLH}	Propagation delay time, low- to high-level output	See Figure 1	9	17	27	ns
t _{PHL}	Propagation delay time, high- to low-level output	See Figure 1	9	17	27	ns
t _{TLH}	Output transition time, low- to high-level output	See Figure 1		4	10	ns
t _{THL}	Output transition time, high- to low-level output	See Figure 1		4	9	ns
t _{PZH}	Output enable time to high level	See Figure 2		13	22	ns
t_{PZL}	Output enable time to low level	See Figure 2		13	22	ns
t _{PHZ}	Output disable time from high level	See Figure 2		13	26	ns
t _{PLZ}	Output disable time from low level	See Figure 2		13	25	ns

⁽¹⁾ All typical values are at V_{CC} = 5 V, T_A = 25°C.

All typical values are at V_{CC} = 5 V, V_{IC} = 0, and T_A = 25°C. The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage.

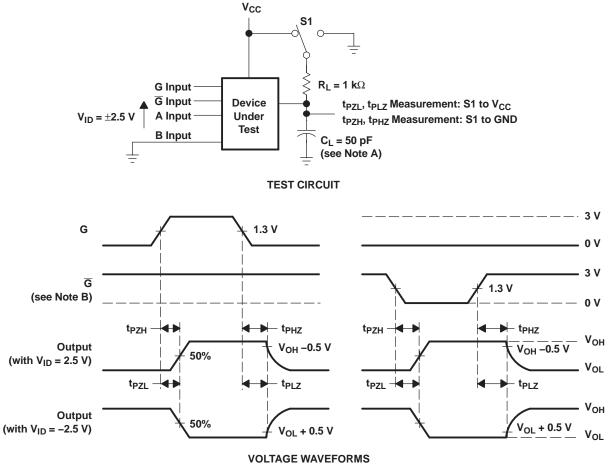


PARAMETER MEASUREMENT INFORMATION



A. C_L includes probe and jig capacitance.

Figure 1. Switching Test Circuit and Voltage Waveforms



- A. C_L includes probe and jig capacitance.
- B. The input pulse is supplied by a generator having the following characteristics: PRR = 1 MHz, duty cycle \leq 50%, $t_r = t_f = 6$ ns.

Figure 2. Enable/Disable Time Test Circuit and Output Voltage Waveforms





11-Apr-2013

PACKAGING INFORMATION

Orderable Device		Package Type	Package Drawing	Pins		Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
AM26C32MDREP	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	26C32EP	Samples
V62/07648-01XE	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	26C32EP	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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OTHER QUALIFIED VERSIONS OF AM26C32-EP:



PACKAGE OPTION ADDENDUM

11-Apr-2013

Military: AM26C32M

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

• Military - QML certified for Military and Defense Applications

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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